

# HAT1046R

Silicon P Channel Power MOS FET  
High Speed Power Switching

# HITACHI

ADE-208-1222 (Z)

1st. Edition

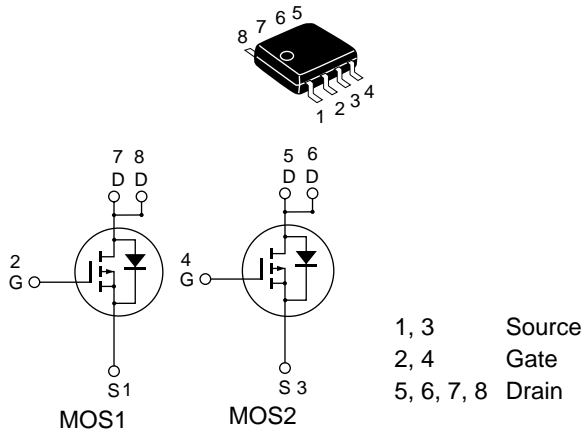
Mar. 2001

## Features

- Low-voltage drive (2.5 V drive)
  - Low on resistance
  - Capable of 4 V gate drive
  - Low on-resistance
- $R_{DS(on)} = 30 \text{ m}\Omega$  typ. (at  $V_{GS} = -4 \text{ V}$ )

## External View

SOP-8



## Absolute Maximum Ratings (Ta = 25°C)

Item	Symbol	Value	Unit
Drain to source voltage	V <sub>DSS</sub>	-20	V
Gate to source voltage	V <sub>GSS</sub>	±12	V
Drain current	I <sub>D</sub>	-6	A
Drain peak current	I <sub>D</sub> (pulse)* <sup>1</sup>	-48	A
Body-drain diode reverse drain current	I <sub>DR</sub>	-6	A
Permissible channel loss	Pch* <sup>2</sup>	2.0	W
	Pch* <sup>2</sup>	3.0	W
Channel temperature	Tch	150	°C
Storage temperature	Tstg	-55 to +150	°C

Notes: 1. PW ≤ 10 μs, duty cycle ≤ 1%

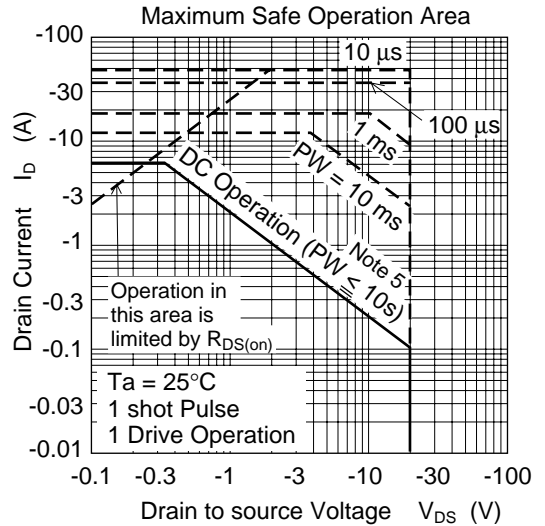
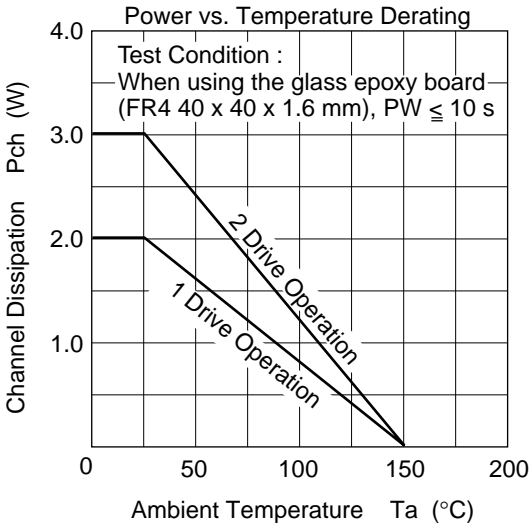
- 1 Drive operation ; When using the glass epoxy board (FR4 40 x 40 x 1.6 mm), PW ≤ 10 s
- 2 Drive operation ; When using the glass epoxy board (FR4 40 x 40 x 1.6 mm), PW ≤ 10 s
4. Value at Tch=25°C, Rg ≥ 50Ω

## Electrical Characteristics

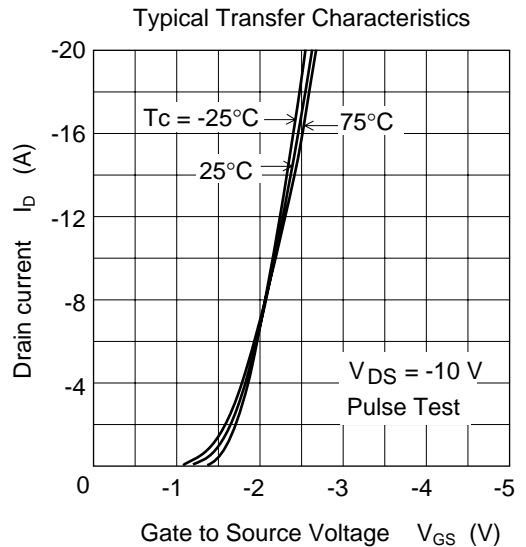
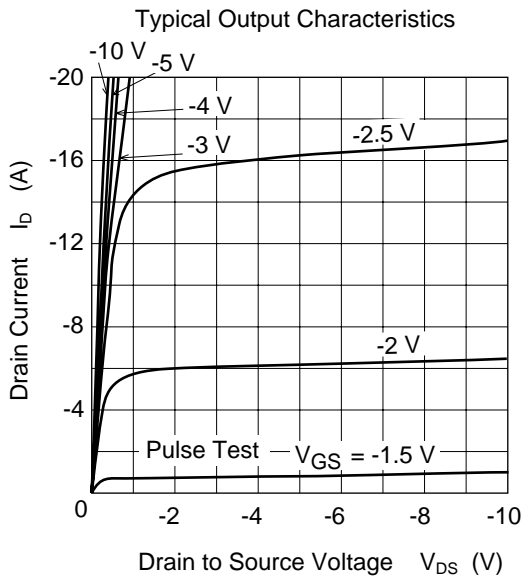
Item	Symbol	Min	Typ	Max	Unit	Test conditions
Drain to source breakdown voltage	$V_{(BR)DSS}$	-20	—	—	V	$I_D = -10 \text{ mA}$ , $V_{GS} = 0$
Gate to source cutoff current	$I_{GSS}$	—	—	$\pm 0.1$	$\mu\text{A}$	$V_{GS} = \pm 12 \text{ V}$ , $V_{DS} = 0$
Zero gate voltage drain current	$I_{DSS}$	—	—	-1	$\mu\text{A}$	$V_{DS} = -20 \text{ V}$ , $V_{GS} = 0$
Gate to source cutoff voltage	$V_{GS(off)}$	-0.4	—	-1.4	V	$V_{DS} = -10 \text{ V}$ , $I_D = -1 \text{ mA}$
Forward transfer admittance	$ y_{fs} $	6.5	11	—	S	$I_D = -3 \text{ A}$ , $V_{DS} = -10 \text{ V}^{*1}$
Static drain to source on state resistance	$R_{DS(on)}$	—	30	40	$\text{m}\Omega$	$I_D = -3 \text{ A}$ , $V_{GS} = -4 \text{ V}^{*1}$
	$R_{DS(on)}$	—	45	60	$\text{m}\Omega$	$I_D = -3 \text{ A}$ , $V_{GS} = -2.5 \text{ V}^{*1}$
Input capacitance	$C_{iss}$	—	1630	—	$\text{pF}$	$V_{DS} = -10 \text{ V}$ , $V_{GS} = 0$
Output capacitance	$C_{oss}$	—	700	—	$\text{pF}$	$f = 1 \text{ MHz}$
Reverse transfer capacitance	$C_{rss}$	—	410	—	$\text{pF}$	
Total gate charge	$Q_g$	—	12	—	nc	$V_{DD} = -10 \text{ V}$
Gate to source charge	$Q_{gs}$	—	8	—	nc	$V_{GS} = -4 \text{ V}$
Gate to drain charge	$Q_{gd}$	—	4	—	nc	$I_D = -6 \text{ A}$
Turn-on delay time	$t_{d(on)}$	—	35	—	ns	$V_{GS} = -4 \text{ V}$ , $I_D = -3 \text{ A}$
Rise time	$t_r$	—	180	—	ns	$V_{DD} \cong -10 \text{ V}$
Turn-off delay time	$t_{d(off)}$	—	155	—	ns	
Fall time	$t_f$	—	185	—	ns	
Body-drain diode forward voltage	$V_{DF}$	—	-0.85	-1.11	V	$I_F = -6 \text{ A}$ , $V_{GS} = 0^{*4}$
Body-drain diode reverse recovery time	$t_{rr}$	—	65	—	ns	$I_F = -6 \text{ A}$ , $V_{GS} = 0$ $diF/dt = 20 \text{ A}/\mu\text{s}$

Note: 1. Pulse measurement

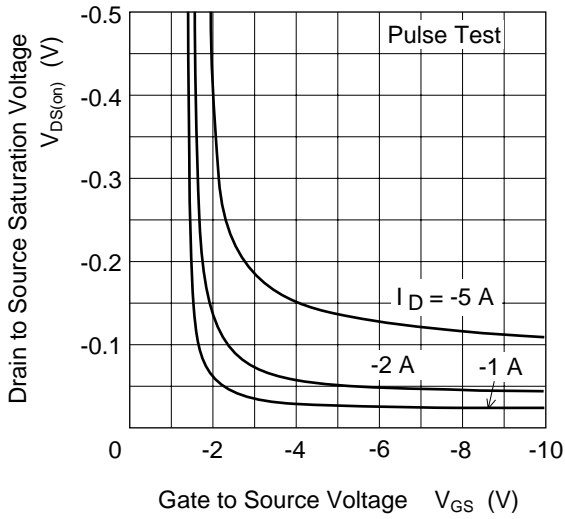
## Main Characteristics



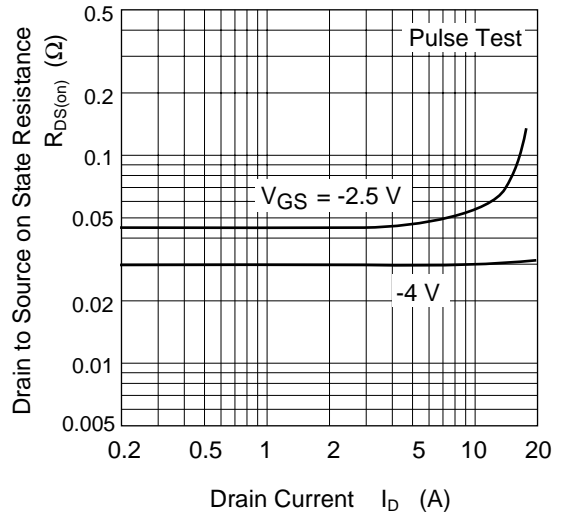
Note 6: When using the glass epoxy board (FR4 40 x 40 x 1.6 mm)



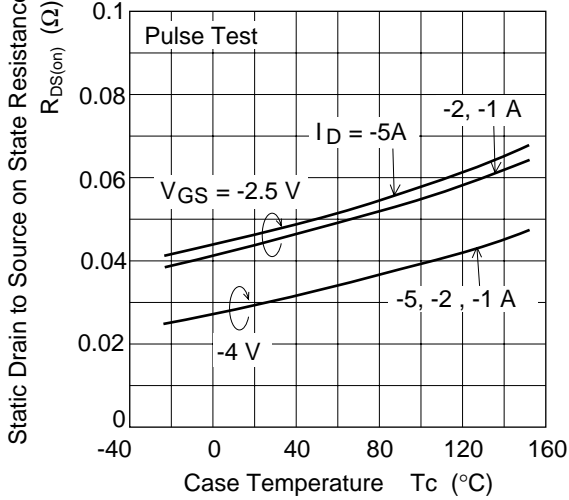
Drain to Source Saturation Voltage vs. Gate to Source Voltage



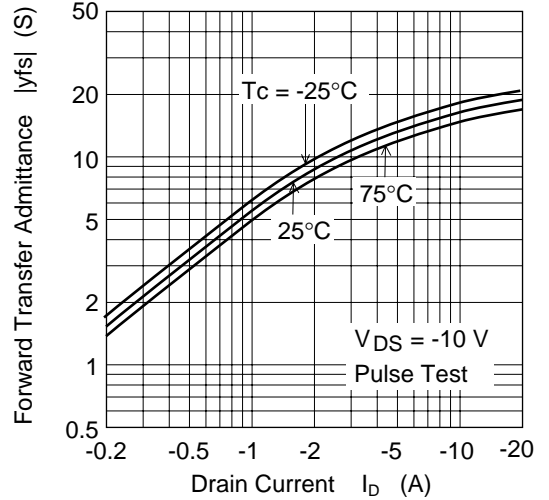
Static Drain to Source on State Resistance vs. Drain Current



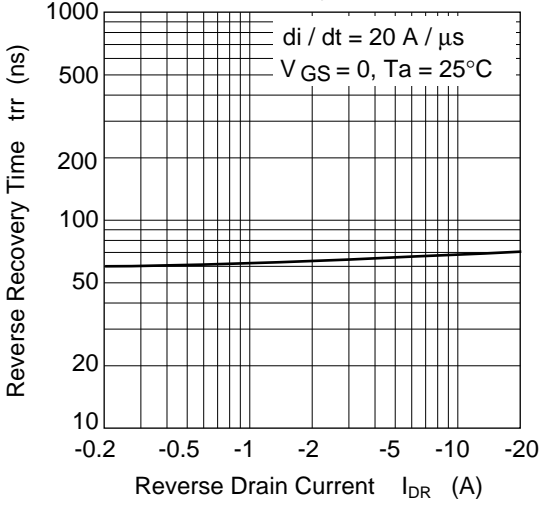
Static Drain to Source on State Resistance vs. Temperature



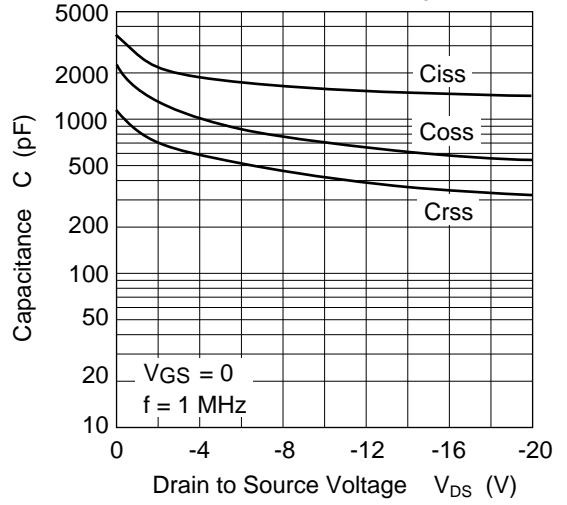
Forward Transfer Admittance vs. Drain Current



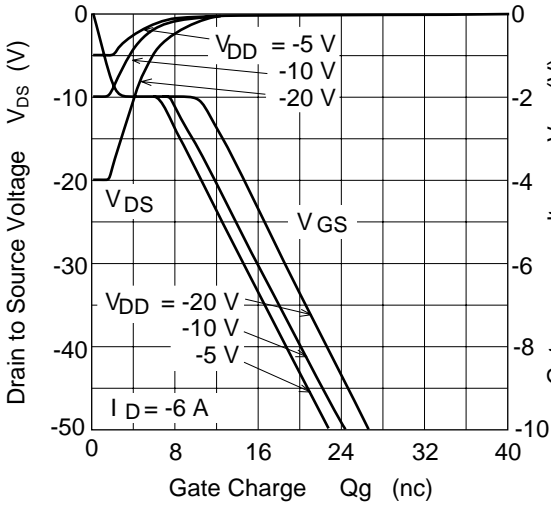
Body-Drain Diode Reverse Recovery Time



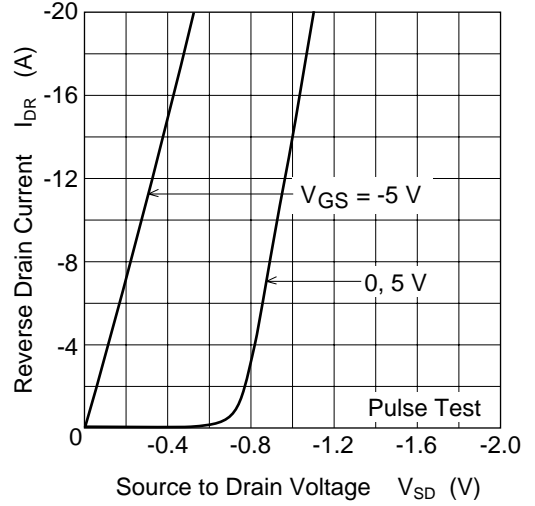
Typical Capacitance vs. Drain to Source Voltage

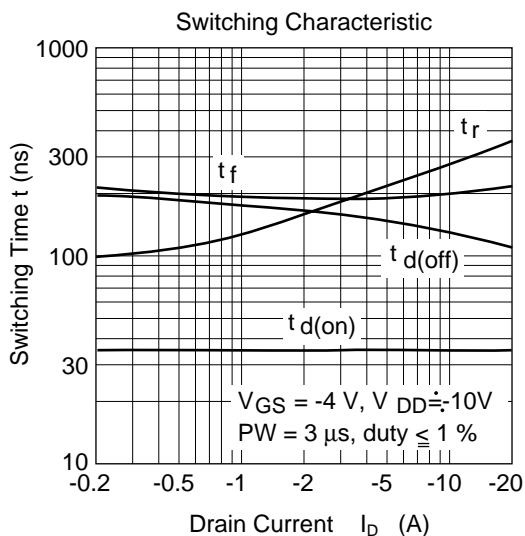


Dynamic Input Characteristics

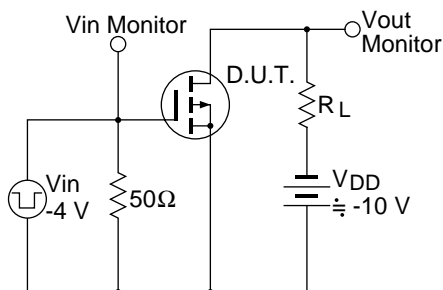


Reverse Drain Current vs. Source to Drain Voltage

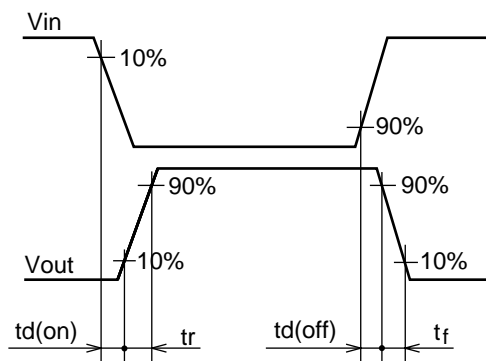




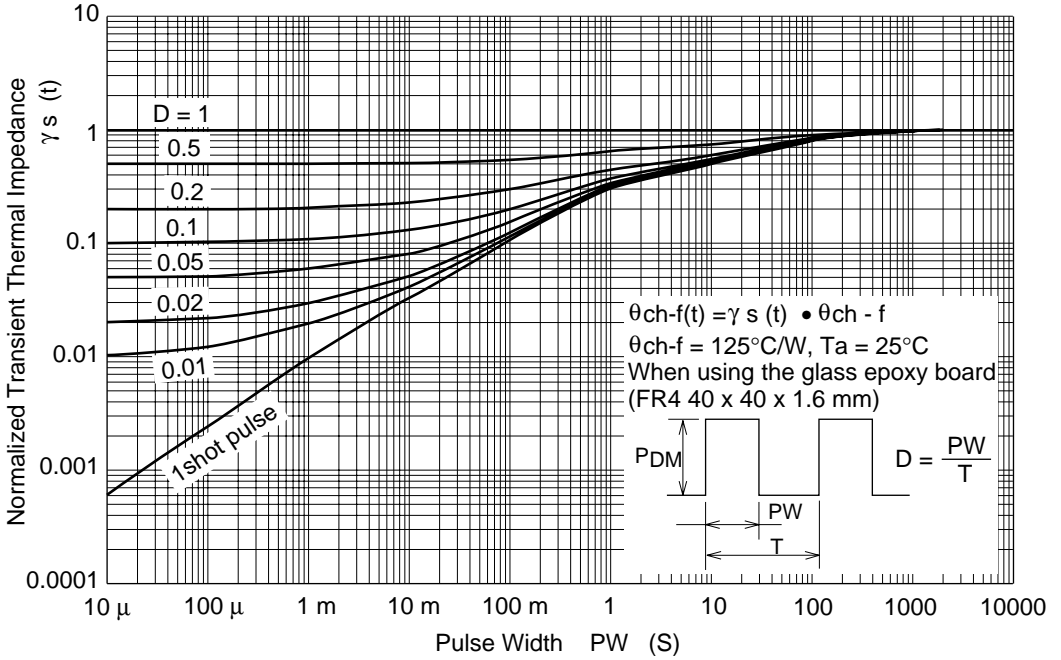
Switching Time Test Circuit



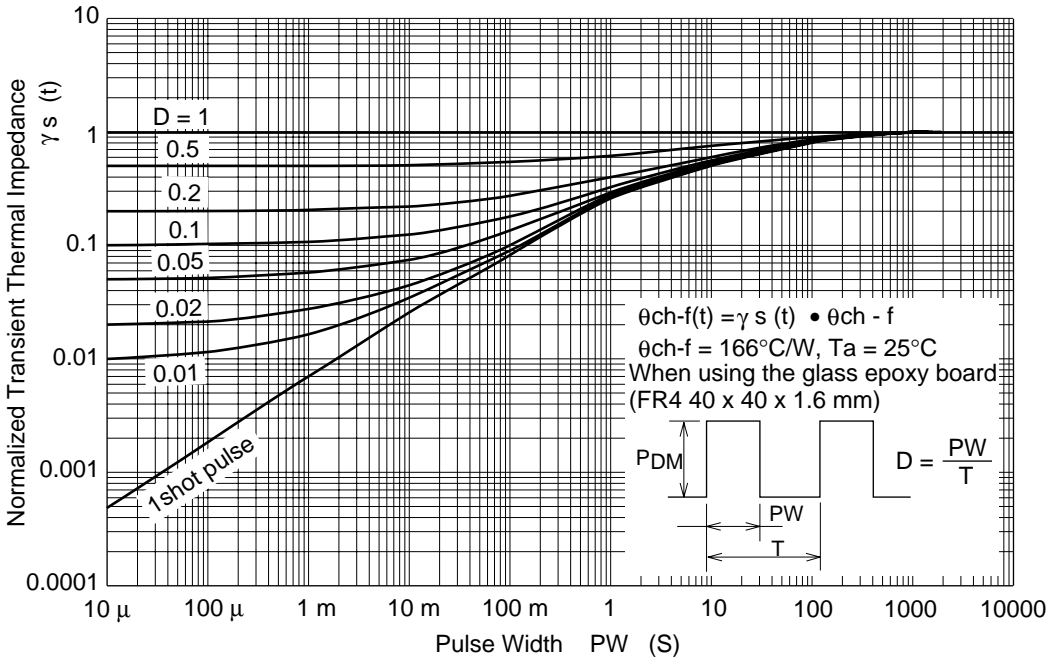
Switching Time Waveform



Normalized Transient Thermal Impedance vs. Pulse Width (1 drive Operation)



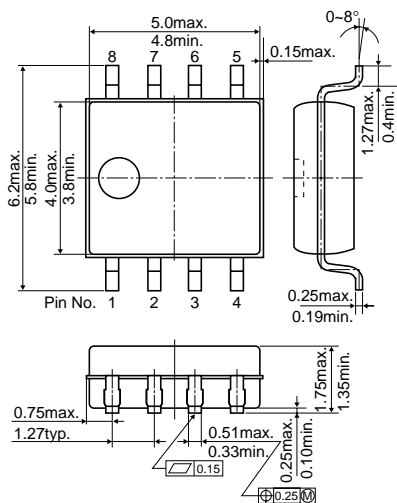
Normalized Transient Thermal Impedance vs. Pulse Width (2 Drive Operation)





Package Dimensions

Unit: mm



Hitachi Code	FP-8DA
JEDEC	—
EIAJ	—

## Cautions

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